

<b>Notice of References Cited</b>	Application/Control No. 10/558,158		Applicant(s)/Patent Under Reexamination HIDAKA ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,201,456	03-2001	Hiratsuka et al.	333/134
*	B	US-6,172,572	01-2001	Kajikawa et al.	331/96
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

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